Power MOSFET 30 V, 53 A, Single N-Channel, SO-8 FL

Features

- Low RDS(on) to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses

Steady

State

t_p=10μs

- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

Gate-to-Source Voltage

Continuous Drain

Power Dissipation

Power Dissipation

Continuous Drain

Power Dissipation

Source Current (Body Diode)

Energy (V_{DD} = 50 V, V_{GS} = 10 V,

 $I_L = 24 A_{pk}, L = 1.0 \text{ mH}, R_G = 25 \Omega$

Lead Temperature for Soldering Purposes

Drain to Source dV/dt

(1/8" from case for 10 s)

Current R_{0.IA}

 $R_{\theta JA}$ (Note 1) Continuous Drain

Current R_{0JA}

R_{0JA} (Note 2)

Current $R_{\theta JC}$

R_{0JC} (Note 1)

Pulsed Drain

(Note 2)

(Note 1)

Current

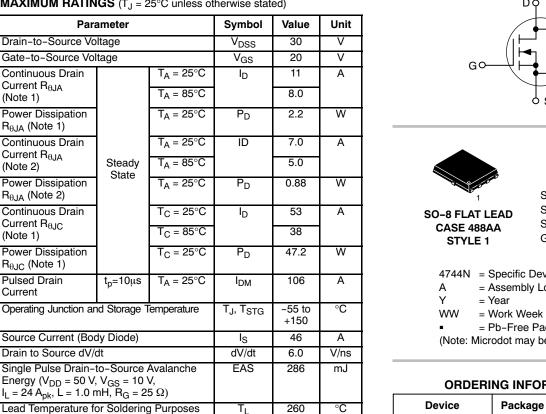
(Note 1)



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http://onsemi.com

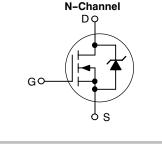
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	10 m Ω @ 10 V	53 A
80 4	14 mΩ @ 4.5 V	30 A



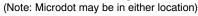
MAXIMUM RATINGS (T_J = 25°C unless otherwise stated) Parameter Drain-to-Source Voltage

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

ΤL







ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4744NT1G	SO-8 FL (Pb-Free)	1500 Tape & Reel
NTMFS4744NT3G	SO-8 FL (Pb-Free)	5000 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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°C

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ hetaJC}$	2.65	
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	56.9	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{ hetaJA}$	142.4	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I _D = 250 μ A		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				10		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25 °C			1.0	
		$v_{\rm DS} = 24 v$	T _J = 125°C			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} = 20 V				100	nA

ON CHARACTERISTICS (Note 3)

Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	$V_{GS} = 10 V to$	I _D = 30 A		7.6		
		11.5 V	I _D = 15 A		7.3		
			I _D = 10 A		7.3	10	
		V _{GS} = 4.5 V	I _D = 30 A		10.4		mΩ
			I _D = 15 A		10.1		
			I _D = 10 A		9.9	14	
Forward Transconductance	9 _{FS}	V _{DS} = 15 V, I _D	= 15 A		25		S

CHARGES, CAPACITANCES & GATE RESISTANCE

Input Capacitance	C _{ISS}		1300		
Output Capacitance	C _{OSS}	V_{GS} = 0 V, f = 1 MHz, V_{DS} = 12 V	550		pF
Reverse Transfer Capacitance	C _{RSS}		132		
Total Gate Charge	Q _{G(TOT)}		10	17	
Threshold Gate Charge	Q _{G(TH)}		0.9		
Gate-to-Source Charge	Q _{GS}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A	1.8		nC
Gate-to-Drain Charge	Q _{GD}		5.9		
Total Gate Charge	Q _{G(TOT)}	V_{GS} = 11.5 V, V_{DS} = 15 V; I _D = 30 A	25	37	nC

SWITCHING CHARACTERISTICS (Note 4)

Turn-On Delay Time	t _{d(ON)}		12	
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V, I _D = 30 A,	203	20
Turn-Off Delay Time	t _{d(OFF)}	$R_G = 3.0 \Omega$	14	ns
Fall Time	t _f		83	

3. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

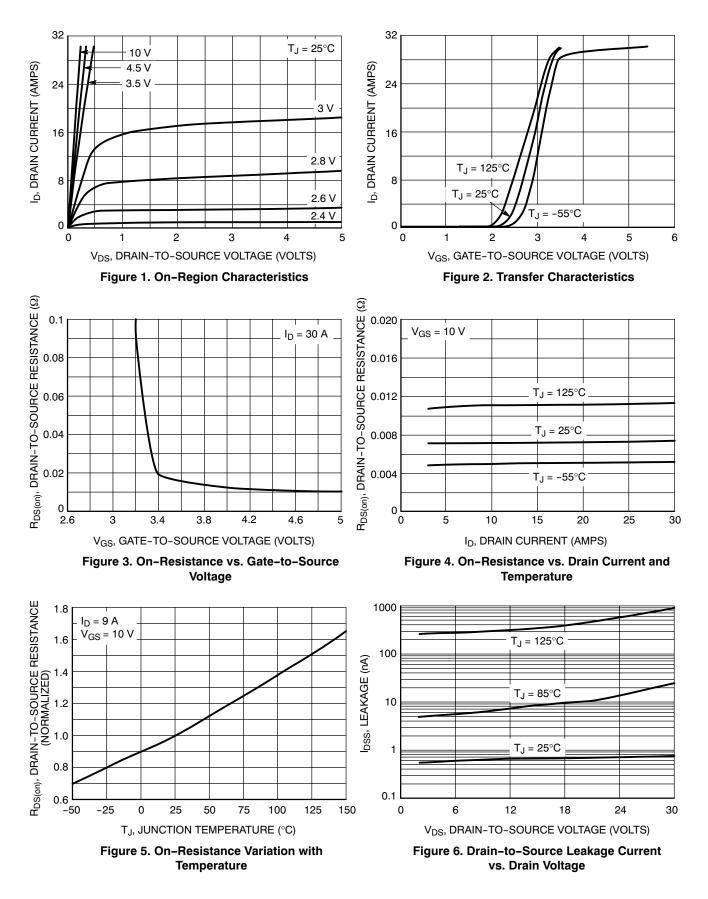
4. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = $25^{\circ}C$ unless otherwise specified)

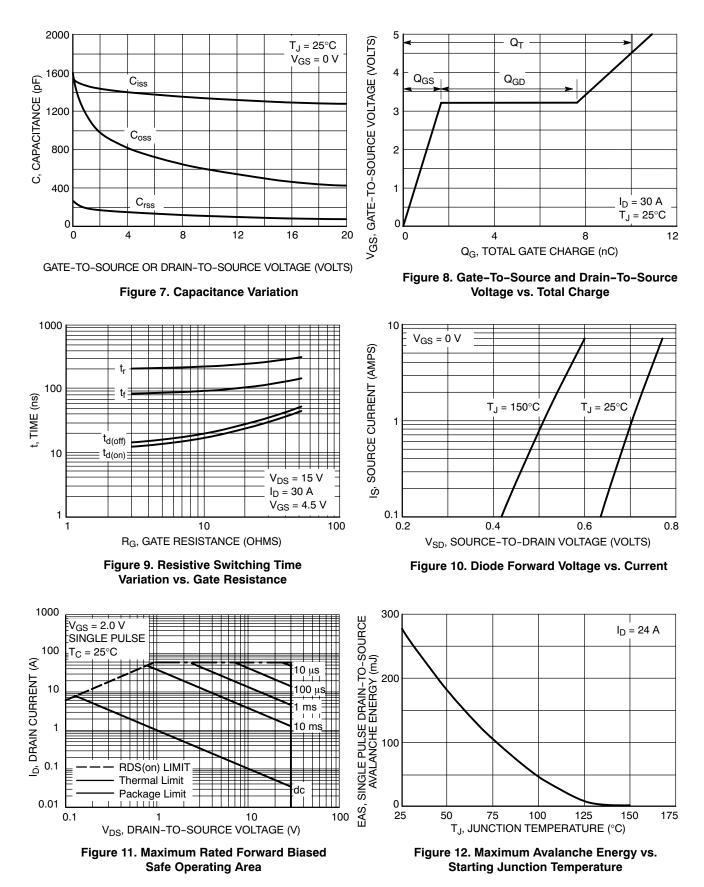
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	ote 4)						
Turn-On Delay Time	t _{d(ON)}	V_{GS} = 11.5 V, V_{DS} = 15 V, I _D = 30 A, R _G = 3.0 Ω			7.0		
Rise Time	t _r				94		ns
Turn-Off Delay Time	t _{d(OFF)}				23		
Fall Time	t _f				4.7		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V, I_{S} = 30 A \qquad T_{J} = 25^{\circ}C T_{J} = 125^{\circ}C$		0.78	1.2		
			T _J = 125°C		0.7		V
Reverse Recovery Time	t _{RR}	•			37	60	
Charge Time	t _a	$V_{GS} = 0 V, dI_S/dt$: = 100 A/μs,		21		ns
Discharge Time	t _b	$V_{GS} = 0 \text{ V, } dI_S/dt$ $I_S = 30$	A		17		
Reverse Recovery Charge	Q _{RR}				37		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				0.65		nH
Drain Inductance	L _D	− T _A = 25°C			0.005		
Gate Inductance	L _G				1.84		
Gate Resistance	R _G				2.0	5.0	Ω

Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
Switching characteristics are independent of operating junction temperatures.

TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES



TYPICAL PERFORMANCE CURVES

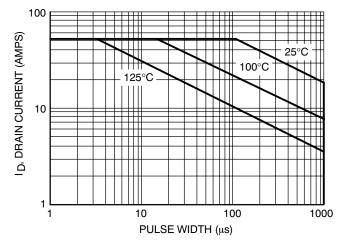
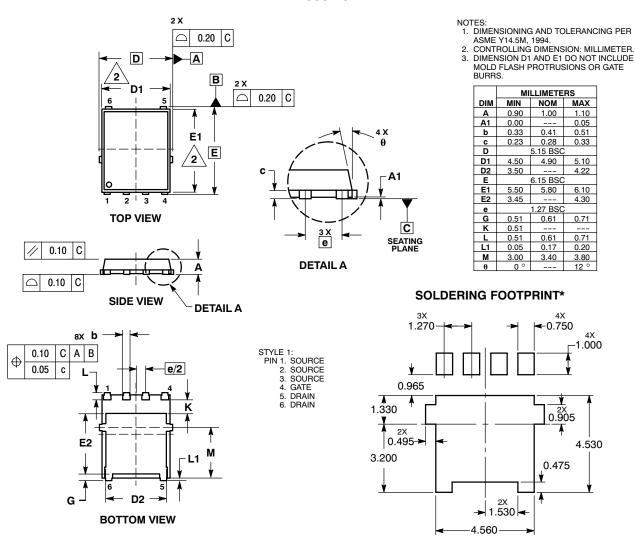


Figure 13. Avalanche Characteristics

PACKAGE DIMENSIONS

DFN6 5x6, 1.27P (SO8 FL) CASE 488AA-01 ISSUE C



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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